

**Search Notes**

Application/Control No.

10/614,207

Examiner

Alain L. Bashore

Applicant(s)/Patent under  
Reexamination

HOSHINO ET AL.

Art Unit

1762

**SEARCHED**

Class	Subclass	Date	Examiner
427	162, 614,165, 166	6/20/2006	ab

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (attached)	6/20/2006	AB
Inventor search	6/20/2006	AB